Preferred Device

SC-59 Quad Monolithic Common Anode

Transient Voltage Suppressors for ESD Protection

This quad monolithic silicon voltage suppressor is designed for applications requiring transient overvoltage protection capability. It is intended for use in voltage and ESD sensitive equipment such as computers, printers, business machines, communication systems, medical equipment, and other applications. Its quad junction common anode design protects four separate lines using only one package. These devices are ideal for situations where board space is at a premium.

Specification Features:

- SC-59 Package Allows Four Separate Unidirectional Configurations
- Peak Power Min. 24 W @ 1.0 ms (Unidirectional), per Figure 5 Waveform
- Peak Power Min. 150 W @ 20 μs (Unidirectional), per Figure 6 Waveform
- Maximum Clamping Voltage @ Peak Pulse Current
- Low Leakage < 2.0 μA
- ESD Rating of Class N (exceeding 16 kV) per the Human Body Model

Mechanical Characteristics:

CASE: Void-free, transfer-molded, thermosetting plastic case **FINISH:** Corrosion resistant finish, easily solderable Package designed for optimal automated board assembly Small package size for high density applications Available in 8 mm Tape and Reel

Use the Device Number to order the 7 inch/3,000 unit reel. Replace the "T1" with "T3" in the Device Number to order the 13 inch/10,000 unit reel.

ON

ON Semiconductor

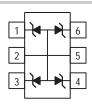
Formerly a Division of Motorola

http://onsemi.com

SC-59 QUAD TRANSIENT VOLTAGE SUPPRESSOR 24 WATTS PEAK POWER 5.6 – 33 VOLTS







PIN 1. CATHODE

- 2. ANODE
- 3. CATHODE
- 4. CATHODE
- 5. ANODE
- 6. CATHODE

ORDERING INFORMATION

| Device | Package | Shipping | | |
|-----------|-----------|------------------------------------|--|--|
| MMQAXXXT1 | CASE 318F | Tape and Reel 3,000 Units/Reel | | |
| MMQAXXXT3 | CASE 318F | Tape and Reel 10,000 Units/Reel | | |

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

| , , , | | | |
|--|----------------------|--------------|-------------|
| Characteristic | Symbol | Value | Unit |
| Peak Power Dissipation @ 1.0 ms (1) @ T _A ≤ 25°C | P _{pk} | 24 | Watts |
| Peak Power Dissipation @ 20 μs (2) @ T _A ≤ 25°C | P _{pk} | 150 | Watts |
| Total Power Dissipation on FR-5 Board (3) @ T _A = 25°C | PD | 225 1.8 | mW mW/°C |
| Thermal Resistance from Junction to Ambient | $R_{	heta JA}$ | 556 | °C/W |
| Total Power Dissipation on Alumina Substrate (4) @ T _A = 25°C Derate above 25°C | PD | 300 2.4 | mW mW/°C |
| Thermal Resistance from Junction to Ambient | $R_{	heta JA}$ | 417 | °C/W |
| Junction and Storage Temperature Range | TJ, T _{stg} | - 55 to +150 | °C |
| Lead Solder Temperature — Maximum (10 Second Duration) | TL | 260 | °C |

- 1. Non-repetitive current pulse per Figure 5 and derate above $T_A = 25^{\circ}C$ per Figure 4.
- 2. Non-repetitive current pulse per Figure 6 and derate above $T_A = 25^{\circ}C$ per Figure 4.
- 3. $FR-5 = 1.0 \times 0.75 \times 0.62 \text{ in.}$
- 4. Alumina = 0.4 x 0.3 x 0.024 in., 99.5% alumina

| | В | Breakdown Voltage | | | Max Reverse Leakage Current | | Max Zener Impedance | Max Reverse Surge | Max Reverse Voltage @ | Maximum Temperature |
|--------------|------|----------------------------|------|-------|--------------------------------|----------------|--|----------------------|----------------------------------|------------------------|
| | | V _{ZT} (5) (V) | | @ lzT | I _R | v _R | (7) | Current | IRSM(6) (Clamping Voltage) | Coefficient of VZ |
| Device | Min | Nom | Max | (mA) | (nA) | (V) | Z _{ZT} @ I _{ZT} (Ω) (mA) | IRSM(4) (A) | V _{RSM} (V) | (mV/°C) |
| MMQA5V6T1,T3 | 5.32 | 5.6 | 5.88 | 1.0 | 2000 | 3.0 | 400 | 3.0 | 8.0 | 1.26 |
| MMQA6V2T1,T3 | 5.89 | 6.2 | 6.51 | 1.0 | 700 | 4.0 | 300 | 2.66 | 9.0 | 10.6 |
| MMQA6V8T1,T3 | 6.46 | 6.8 | 7.14 | 1.0 | 500 | 4.3 | 300 | 2.45 | 9.8 | 10.9 |
| MMQA12VT1,T3 | 11.4 | 12 | 12.6 | 1.0 | 75 | 9.1 | 80 | 1.39 | 17.3 | 14 |
| MMQA13VT1,T3 | 12.4 | 13 | 13.7 | 1.0 | 75 | 9.8 | 80 | 1.29 | 18.6 | 15 |
| MMQA15VT1,T3 | 14.3 | 15 | 15.8 | 1.0 | 75 | 11 | 80 | 1.1 | 21.7 | 16 |
| MMQA18VT1,T3 | 17.1 | 18 | 18.9 | 1.0 | 75 | 14 | 80 | 0.923 | 26 | 19 |
| MMQA20VT1,T3 | 19 | 20 | 21 | 1.0 | 75 | 15 | 80 | 0.84 | 28.6 | 20.1 |
| MMQA21VT1,T3 | 20 | 21 | 22.1 | 1.0 | 75 | 16 | 80 | 0.792 | 30.3 | 21 |
| MMQA22VT1,T3 | 20.9 | 22 | 23.1 | 1.0 | 75 | 17 | 80 | 0.758 | 31.7 | 22 |
| MMQA24VT1,T3 | 22.8 | 24 | 25.2 | 1.0 | 75 | 18 | 100 | 0.694 | 34.6 | 25 |
| MMQA27VT1,T3 | 25.7 | 27 | 28.4 | 1.0 | 75 | 21 | 125 | 0.615 | 39 | 28 |
| MMQA30VT1,T3 | 28.5 | 30 | 31.5 | 1.0 | 75 | 23 | 150 | 0.554 | 43.3 | 32 |
| MMQA33VT1,T3 | 31.4 | 33 | 34.7 | 1.0 | 75 | 25 | 200 | 0.504 | 48.6 | 37 |

 $[\]text{V}_{\text{Z}}$ measured at pulse test current I_{T} at an ambient temperature of 25°C.

NOTE: SPECS LISTED ABOVE ARE PRELIMINARY

TYPICAL CHARACTERISTICS

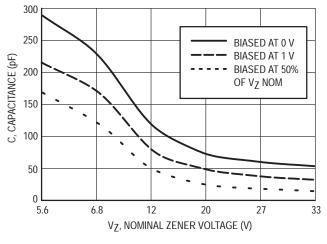


Figure 1. Typical Capacitance

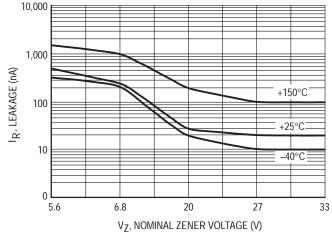


Figure 2. Typical Leakage Current

Surge current waveform per Figure 5 and derate per Figure 4.

 Z_{ZT} is measured by dividing the AC voltage drop across the device by the AC current supplied. The specified limits are $I_{Z(AC)} = 0.1 I_{Z(DC)}$, with AC frequency = 1 kHz.

TYPICAL CHARACTERISTICS

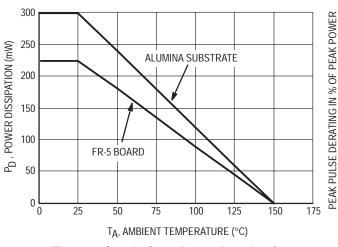


Figure 3. Steady State Power Derating Curve

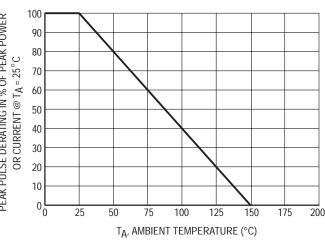


Figure 4. Pulse Derating Curve

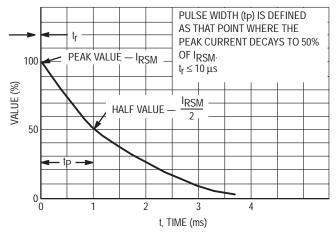


Figure 5. $10 \times 1000 \mu s$ Pulse Waveform

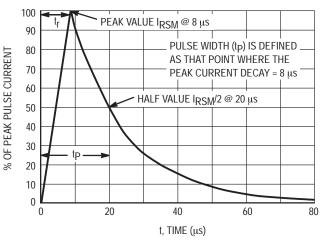


Figure 6. $8 \times 20 \mu s$ Pulse Waveform

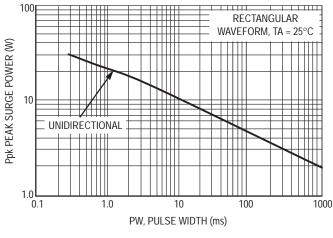


Figure 7. Maximum Non–Repetitive Surge Power, Ppk versus PW

Power is defined as $V_{RSM} \times I_Z(pk)$ where V_{RSM} is the clamping voltage at $I_Z(pk)$.

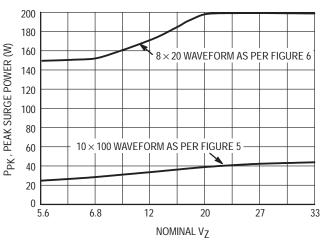


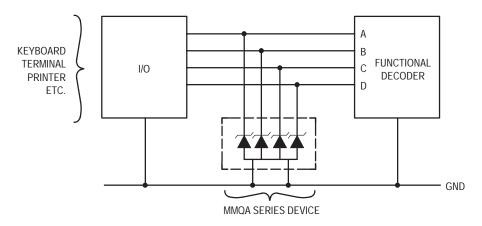
Figure 8. Typical Maximum Non-Repetitive Surge Power, Ppk versus VBR

TYPICAL COMMON ANODE APPLICATIONS

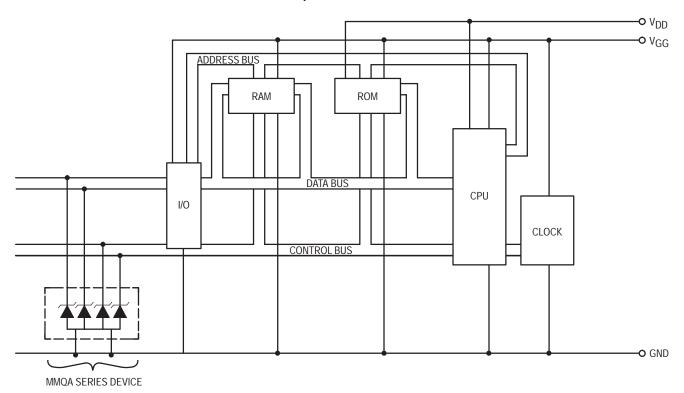
A quad junction common anode design in a SC-59 package protects four separate lines using only one package. This adds flexibility and creativity to PCB design especially

when board space is at a premium. A simplified example of MMQA Series Device applications is illustrated below.

Computer Interface Protection



Microprocessor Protection

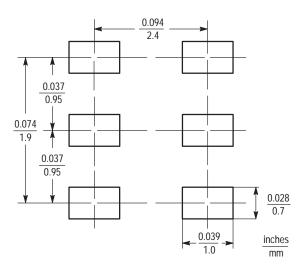


INFORMATION FOR USING THE SC-59 6 LEAD SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to ensure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self-align when subjected to a solder reflow process.



SC-59 6 LEAD

SC-59 6 LEAD POWER DISSIPATION

The power dissipation of the SC-59 6 Lead is a function of the pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A . Using the values provided on the data sheet for the SC-59 6 Lead package, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C,

one can calculate the power dissipation of the device which in this case is 225 milliwatts.

$$P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{556^{\circ}C/W} = 225 \text{ milliwatts}$$

The 556°C/W for the SC-59 6 Lead package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 225 milliwatts. There are other alternatives to achieving higher power dissipation from the SC-59 6 Lead package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

SOLDER STENCIL GUIDELINES

Prior to placing surface mount components onto a printed circuit board, solder paste must be applied to the pads. Solder stencils are used to screen the optimum amount. These stencils are typically 0.008 inches thick and may be made of brass or stainless steel. For packages such

as the SC-59, SC-59 6 Lead, SC-70/SOT-323, SOD-123, SOT-23, SOT-143, SOT-223, SO-8, SO-14, SO-16, and SMB/SMC diode packages, the stencil opening should be the same as the pad size or a 1:1 registration.

SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference should be a maximum of 10°C.

- * Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.
- The soldering temperature and time should not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient should be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes.
 Gradual cooling should be used since the use of forced cooling will increase the temperature gradient and will result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones and a figure for belt speed. Taken together, these control settings make up a heating "profile" for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 9 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems, but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows temperature versus time.

The line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between 177–189°C. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.

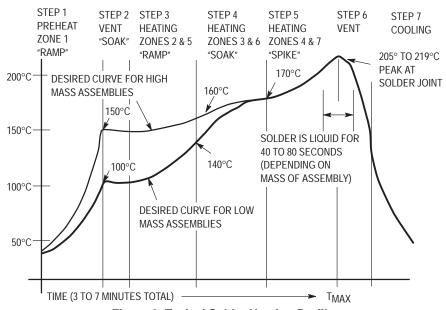
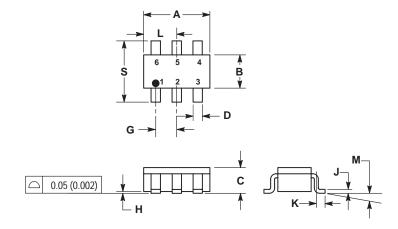


Figure 9. Typical Solder Heating Profile

Transient Voltage Suppressors — Surface Mount

24 Watts Peak Power



CASE 318F-01 **ISSUE A SC-59 6 LEAD**

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE

 MATERIAL. MATERIAL.

| | INC | HES | MILLIMETERS | | |
|-----|--------|--------|-------------|-------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 0.1063 | 0.1220 | 2.70 | 3.10 | |
| В | 0.0512 | 0.0669 | 1.30 | 1.70 | |
| С | 0.0394 | 0.0511 | 1.00 | 1.30 | |
| D | 0.0138 | 0.0196 | 0.35 | 0.50 | |
| G | 0.0335 | 0.0413 | 0.85 | 1.05 | |
| Н | 0.0005 | 0.0040 | 0.013 | 0.100 | |
| J | 0.0040 | 0.0102 | 0.10 | 0.26 | |
| K | 0.0079 | 0.0236 | 0.20 | 0.60 | |
| L | 0.0493 | 0.0649 | 1.25 | 1.65 | |
| M | 0° | 10° | 0° | 10° | |
| S | 0.0985 | 0.1181 | 2.50 | 3.00 | |

- STYLE 1: PIN 1. CATHODE

 - 2. ANODE 3. CATHODE 4. CATHODE 5. ANODE

 - 6. CATHODE

(Refer to Section 10 of the TVS/Zener Data Book (DL150/D) for Surface Mount, Thermal Data and Footprint Information.)

Thermal Clad is a trademark of the Bergquist Company

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